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| Notice of References Cited | Application/Control No. 10/648,193 | Applicant(s)/Patent Under Reexamination NAGAOKA ET AL. | |
| | Examiner BINH Q. TRAN | Art Unit 3748 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-5,832,722 | 11-1998 | Cullen et al. | 60/274 |
| | B | US-6,173,571 B1 | 01-2001 | Kaneko et al. | 60/286 |
| | C | US-5,778,666 A | 07-1998 | Cullen et al. | 60/274 |
| | D | US-5,974,788 A | 11-1999 | Hepburn et al. | 60/274 |
| | E | US-6,199,372 B1 | 03-2001 | Wakamoto, Koutaro | 60/274 |
| | F | US-6,644,021 B2 | 11-2003 | Okada et al. | 60/286 |
| | G | US-6,233,925 B1 | 05-2001 | Hirota et al. | 60/285 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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